


<b>Search Notes</b>  	<b>Application/Control No.</b>  10656507	<b>Applicant(s)/Patent Under Reexamination</b>  OSHIMA ET AL.
	<b>Examiner</b>  Revak, Christopher A	<b>Art Unit</b>  2131

SEARCHED			
Class	Subclass	Date	Examiner
none	none	2/12/07	CR

SEARCH NOTES		
Search Notes	Date	Examiner
BRS Text Search: USPAT, US PGPUB, USOCR, DERWENT, FPRS, IBM TDB, EPO, JPO (see attached strategy)	2/12/07	CR
Interference Search (see attached strategy)	2/12/07	CR
DIALOG Text Search: COMPSCI, ELECTRON, SOFTWARE (see attached strategy)	2/12/07	CR

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
713	1,2,100	2/12/07	CR
726	1-4,22-24	2/12/07	CR
709	217-219,223,224	2/12/07	CR
707	1,9,10,200-204	2/12/07	CR
717	168-171,174-176	2/12/07	CR